

Title: Case A10 (Manufacturing quality from images)

Sub Title: AI-Driven Quality Inspection: Detecting Rare Defects via Anomaly Detection

Date: Antonios Simeonidis 09.02.2026

A3 Control Number: A10

Customer: NeueFische

International - Other

Implementation Year: 2026 CN60

Program Name: AI-T11

Enter here

Market

EU

N/A

N/A

Problem Type

Other

Occurrence Type (Pick One Below)

General check

SIGNATURES

Approver

SIA

09.02.26

Checker SIA

Date

Checker

Date

Owner/Writer

Date

PROBLEM DESCRIPTION

Background:

Our production line captures images, but we face high costs from rare defects. Currently, there is no automation. We cannot use standard AI because we lack a "defect library." Goal: Detect defects automatically using only "normal" product data.

Problem Statement:

How can we automatically flag product defects using production line images when clean labeled training data does not exist and failures are rare? The system must identify costly defects by discovering structures in the data before prediction is possible.

Analysis / Problem Type:

Unsupervised Learning (Anomaly Detection). We cannot use standard supervised classification because we lack consistent labels and the classes are extremely imbalanced. We must model the "normal" production state and identify anything else as a defect. (NO OUTLIER)

Data Scope:

Data: Images (Computer Vision).
Granularity: Item-level.
Labels: None. Risks: Changes in lighting, camera vibration, or product orientation (Ishikawa factors).

PROPOSED SOLUTIONS

Countermeasures (Models):

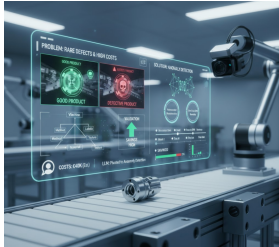
1. Autoencoders: These learn to recreate "perfect" images. A high reconstruction error flags a defect.
2. One-Class SVM: Creates a safety boundary around "normal" data. (Support Vector Machine)
3. Inappropriate: Supervised CNNs (due to data sparsity).(Convolutional Neural Networks)

Discovery:

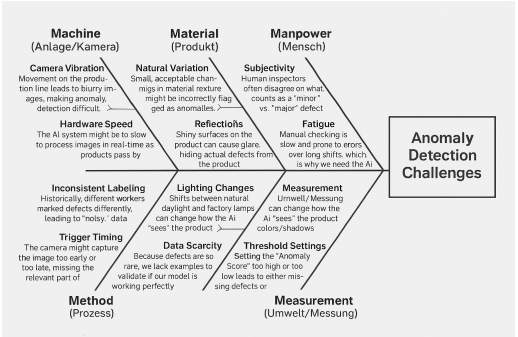
Self-Supervised Learning (SSL). The model teaches itself by solving puzzles (like image rotation) to understand product features without needing human labels. I initially thought we needed a "Defect Library" before starting.

LLM Reflection:

We used the LLM as a brainstorming partner for our project. Initially, the LLM suggested a standard classification model. We corrected this approach because our dataset lacks enough labeled defect images. This collaborative process helped us shift our strategy toward **Anomaly Detection**, which allows us to start the project using only images of 'good' products.



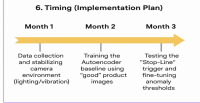
ISHIKAWA influence outcome performance



TIMING, SUCCESS & COSTS

Timing (Implementation Plan)

- Month 1: Data collection and stabilizing camera environment (lighting/vibration).
Month 2: Training the Autoencoder baseline using "good" product images.
Month 3: Testing the "Stop-Line" trigger and fine-tuning anomaly thresholds.



Reflection & Validation (How we know it's OK).

- We will validate the system by inserting a small set of "known defects" (test samples) into the line.
- Success Metric: Detection Rate (Recall). If the system flags 98% of known test-defects without too many false alarms, the project is successful.
 - LLM Role: We used the LLM to verify that "Reconstruction Loss" is the right metric for this task.

Cost Estimation

- Infrastructure: Low (using existing cameras) if possible need to validate.
- Development: Medium (Data Scientist for 3 months).
- Potential Savings: High (reduction in scrap costs and customer complaints).
- Total Est: €30,000 - €50,000 (Initial Setup).